

PowerMOS transistor

Logic Level FET

BUK552-50A
BUK552-50B

GENERAL DESCRIPTION

N-channel enhancement mode logic level field-effect power transistor in a plastic envelope. The device is intended for use in Switched Mode Power Supplies (SMPS), motor control, welding, DC/DC and AC/DC converters, and in general purpose switching applications.

QUICK REFERENCE DATA

| SYMBOL | PARAMETER | BUK552 | MAX. | MAX. | UNIT |
|--------------|--|--------|------|------|------|
| V_{DS} | Drain-source voltage | -50A | -50B | | V |
| I_D | Drain current (DC) | 50 | 50 | | A |
| P_{tot} | Total power dissipation | 14 | 13 | | W |
| T_j | Junction temperature | 60 | 60 | | °C |
| $R_{DS(ON)}$ | Drain-source on-state resistance $V_{GS} = 5 \text{ V}$ | 0.15 | 0.18 | | Ω |

MECHANICAL DATA

Dimensions in mm

Net Mass: 2g

Pinning:

- 1 = Gate
- 2 = Drain
- 3 = Source

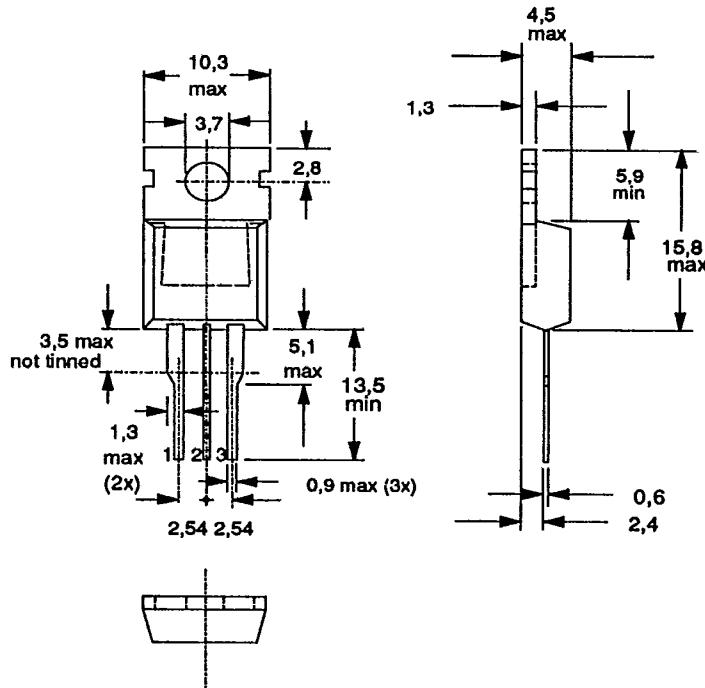
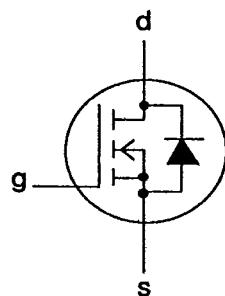


Fig. 1 TO220AB; drain connected to mounting base.

Notes

1. Observe the general handling precautions for electrostatic-discharge sensitive devices (ESDs) to prevent damage to MOS gate oxide.
2. Accessories supplied on request: refer to Mounting instructions for TO220 envelopes.

PowerMOS transistor
Logic Level FET
BUK552-50A
BUK552-50B

T-39-11

RATINGS

Limiting values in accordance with the Absolute Maximum System (IEC 134)

| SYMBOL | PARAMETER | CONDITIONS | MIN. | MAX. | | UNIT |
|---------------------------------------|----------------------------------|-------------------------------|------|------|------|------|
| V_{DS} V_{PGR} $\pm V_{GS}$ | Drain-source voltage | $R_{GS} = 20 \text{ k}\Omega$ | - | 50 | | V |
| | Drain-gate voltage | | - | 50 | | V |
| | Gate-source voltage | | - | 15 | | V |
| I_D I_D^P I_{DM} | Drain current (DC) | $T_{mb} = 25^\circ\text{C}$ | - | -50A | -50B | A |
| | Drain current (DC) | | - | 14 | 13 | A |
| | Drain current (pulse peak value) | | - | 10 | 9 | A |
| P_{tot} T_{stg} T_J | Total power dissipation | $T_{mb} = 25^\circ\text{C}$ | - | 60 | | W |
| | Storage temperature | | -55 | 175 | | °C |
| | Junction Temperature | | - | 175 | | °C |

THERMAL RESISTANCES

| | |
|--------------------------------|--------------------------------|
| From junction to mounting base | $R_{thj-mb} = 2.5 \text{ K/W}$ |
| From junction to ambient | $R_{thj-a} = 60 \text{ K/W}$ |

STATIC CHARACTERISTICS $T_{mb} = 25^\circ\text{C}$ unless otherwise specified

| SYMBOL | PARAMETER | CONDITIONS | MIN. | TYP. | MAX. | UNIT |
|---------------|----------------------------------|--|------|------|------|---------------|
| $V_{(BR)DSS}$ | Drain-source breakdown voltage | $V_{GS} = 0 \text{ V}; I_D = 0.25 \text{ mA}$ | 50 | - | - | V |
| $V_{GS(TO)}$ | Gate threshold voltage | $V_{DS} = V_{GS}; I_D = 1 \text{ mA}$ | 1.0 | 1.5 | 2.0 | V |
| I_{DSS} | Zero gate voltage drain current | $V_{DS} = 50 \text{ V}; V_{GS} = 0 \text{ V}; T_J = 25^\circ\text{C}$ | - | 1 | 10 | μA |
| I_{DS} | Zero gate voltage drain current | $V_{DS} = 50 \text{ V}; V_{GS} = 0 \text{ V}; T_J = 125^\circ\text{C}$ | - | 0.1 | 1.0 | mA |
| I_{GSS} | Gate source leakage current | $V_{GS} = \pm 15 \text{ V}; V_{DS} = 0 \text{ V}$ | - | 10 | 100 | nA |
| $R_{DS(ON)}$ | Drain-source on-state resistance | $V_{GS} = 5 \text{ V}; I_D = 8.5 \text{ A}$ BUK552-50A $V_{GS} = 5 \text{ V}; I_D = 8.5 \text{ A}$ BUK552-50B | - | 0.12 | 0.15 | Ω |
| | | | - | 0.15 | 0.18 | Ω |

DYNAMIC CHARACTERISTICS $T_{mb} = 25^\circ\text{C}$ unless otherwise specified

| SYMBOL | PARAMETER | CONDITIONS | MIN. | TYP. | MAX. | UNIT |
|---|--|---|------|------|------|------|
| g_{fs} | Forward transconductance | $V_{DS} = 25 \text{ V}; I_D = 8.5 \text{ A}$ | 5 | 6.7 | - | S |
| C_{iss} C_{oss} C_{rss} | Input capacitance Output capacitance Feedback capacitance | $V_{GS} = 0 \text{ V}; V_{DS} = 25 \text{ V}; f = 1 \text{ MHz}$ | - | 400 | 600 | pF |
| $t_{d(on)}$ t_r $t_{d(off)}$ t_f | Turn-on delay time Turn-on rise time Turn-off delay time Turn-off fall time | $V_{DD} = 30 \text{ V}; I_D = 3 \text{ A};$ $V_{GS} = 5 \text{ V}; R_{GS} = 50 \Omega;$ $R_{gen} = 50 \Omega$ | - | 12 | 18 | ns |
| t_r | | | - | 60 | 80 | ns |
| $t_{d(off)}$ | | | - | 50 | 70 | ns |
| t_f | | | - | 45 | 70 | ns |
| L_d | Internal drain inductance | Measured from contact screw on tab to centre of die | - | 3.5 | - | nH |
| L_d | Internal drain inductance | Measured from drain lead 6 mm from package to centre of die | - | 4.5 | - | nH |
| L_s | Internal source inductance | Measured from source lead 6 mm from package to source bond pad | - | 7.5 | - | nH |

PowerMOS transistor

Logic Level FET

BUK552-50A
BUK552-50B

T-39-11

REVERSE DIODE RATINGS AND CHARACTERISTICS

 $T_{mb} = 25^\circ\text{C}$ unless otherwise specified

| SYMBOL | PARAMETER | CONDITIONS | MIN. | TYP. | MAX. | UNIT |
|-----------|----------------------------------|--|------|------|------|---------------|
| I_{DR} | Continuous reverse drain current | - | - | - | 14 | A |
| I_{DRM} | Pulsed reverse drain current | - | - | - | 56 | A |
| V_{SD} | Diode forward voltage | $I_F = 14 \text{ A}; V_{GS} = 0 \text{ V}$ | - | 1.3 | 1.7 | V |
| t_{rr} | Reverse recovery time | $I_F = 14 \text{ A}; -dI_F/dt = 100 \text{ A}/\mu\text{s}$ | - | 120 | - | ns |
| Q_{rr} | Reverse recovery charge | $V_{GS} = 0 \text{ V}; V_R = 30 \text{ V}$ | - | 0.15 | - | μC |

AVALANCHE RATING

 $T_{mb} = 25^\circ\text{C}$ unless otherwise specified

| SYMBOL | PARAMETER | CONDITIONS | MIN. | TYP. | MAX. | UNIT |
|-----------|---|--|------|------|------|------|
| W_{DSS} | Drain-source non-repetitive unclamped inductive turn-off energy | $I_D = 14 \text{ A}; V_{DD} \leq 25 \text{ V}; V_{GS} = 5 \text{ V}; R_{GS} = 50 \Omega$ | - | - | 30 | mJ |

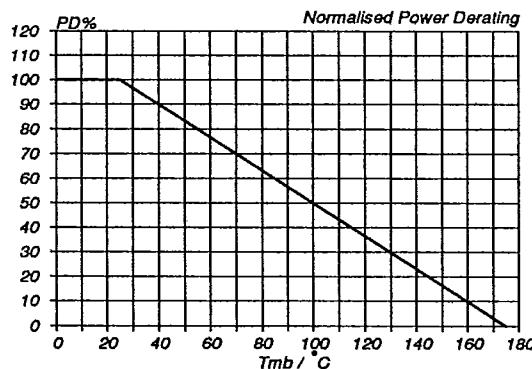


Fig.2. Normalised power dissipation.
 $PD\% = 100 \cdot P_D / P_{D, 25^\circ\text{C}} = f(T_{mb})$

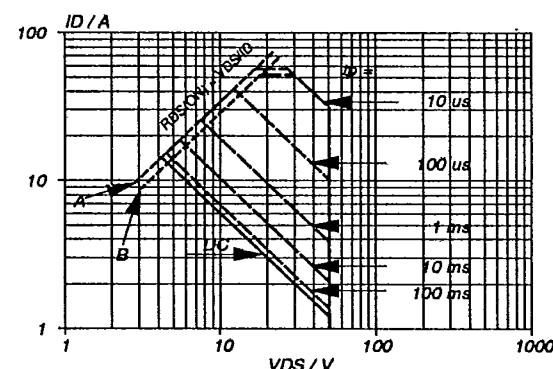


Fig.4. Safe operating area. $T_{mb} = 25^\circ\text{C}$
 I_D & $I_{DM} = f(V_{DS})$; I_{DM} single pulse; parameter t_p

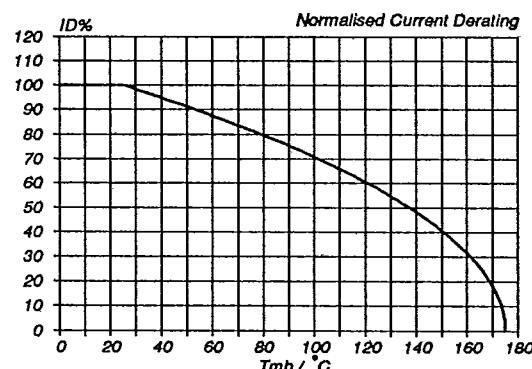


Fig.3. Normalised continuous drain current.
 $ID\% = 100 \cdot I_D / I_{D, 25^\circ\text{C}} = f(T_{mb})$; conditions: $V_{GS} \geq 5 \text{ V}$

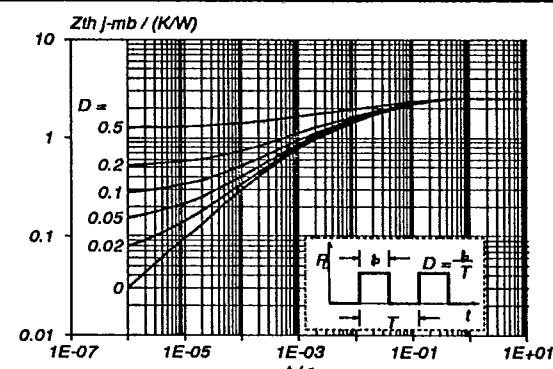


Fig.5. Transient thermal impedance.
 $Z_{th,j-mb} = f(t)$; parameter $D = t_p/T$

PowerMOS transistor
Logic Level FET

BUK552-50A
BUK552-50B

T-39-11

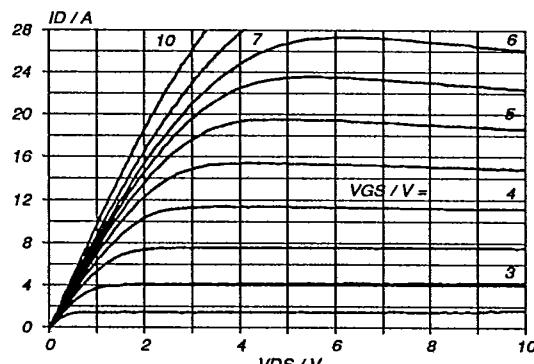


Fig.6. ¹ Typical output characteristics, $T_j = 25^\circ\text{C}$.
 $I_D = f(V_{DS})$; parameter V_{GS}

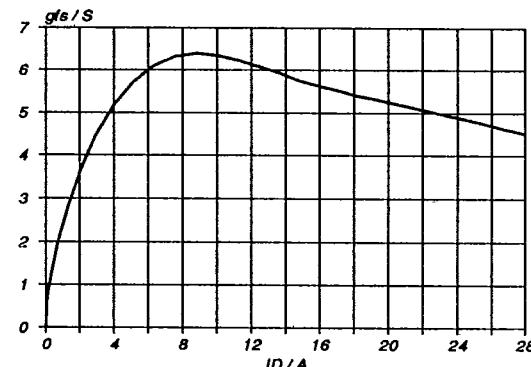


Fig.9. Typical transconductance, $T_j = 25^\circ\text{C}$.
 $g_{fs} = f(I_D)$; conditions: $V_{DS} = 25\text{ V}$

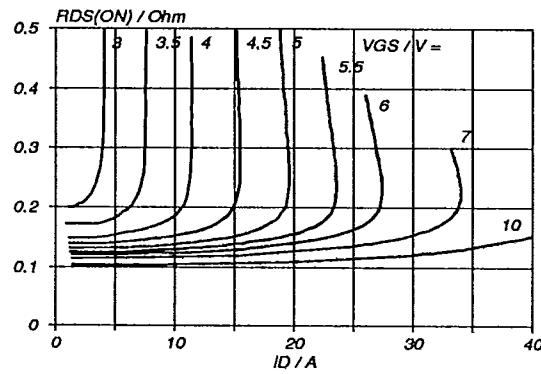


Fig.7. Typical on-state resistance, $T_j = 25^\circ\text{C}$.
 $R_{DS(ON)} = f(I_D)$; parameter V_{GS}

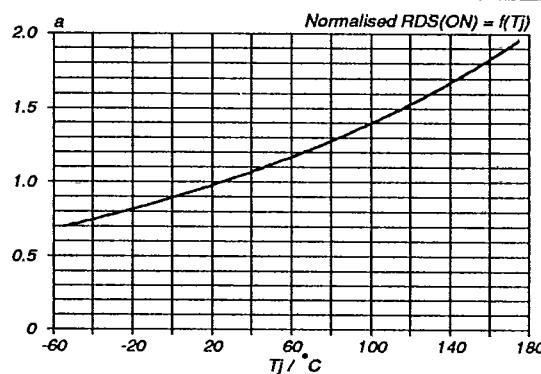


Fig.10. Normalised drain-source on-state resistance.
 $a = R_{DS(ON)}/R_{DS(ON)25^\circ\text{C}} = f(T_j)$; $I_D = 8.5\text{ A}$; $V_{GS} = 5\text{ V}$

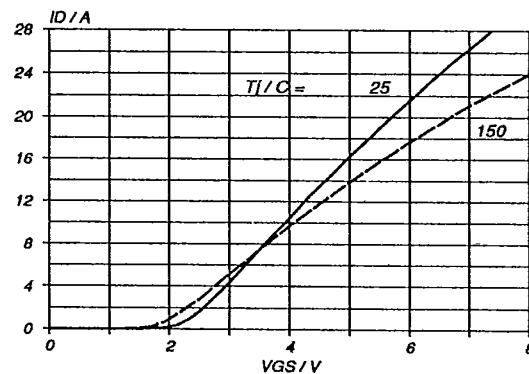


Fig.8. Typical transfer characteristics.
 $I_D = f(V_{GS})$; conditions: $V_{DS} = 25\text{ V}$; parameter T_j

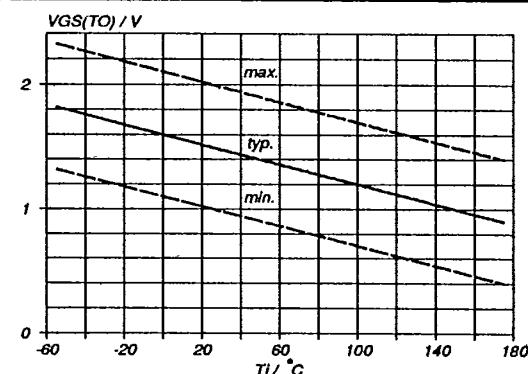


Fig.11. Gate threshold voltage.
 $V_{GS(TO)} = f(T_j)$; conditions: $I_D = 1\text{ mA}$; $V_{DS} = V_{GS}$

PowerMOS transistor
Logic Level FET

BUK552-50A
BUK552-50B

T-39-11

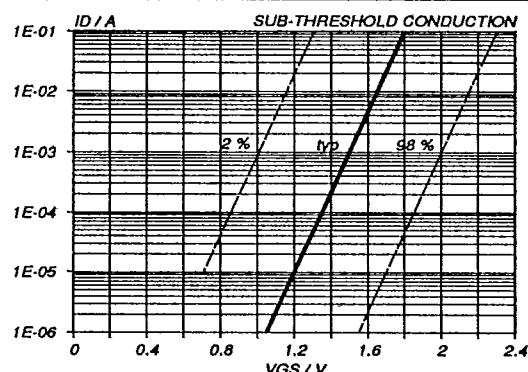


Fig. 12. Sub-threshold drain current.
 $I_D = f(V_{GS})$; conditions: $T_J = 25^\circ\text{C}$; $V_{DS} = V_{GS}$

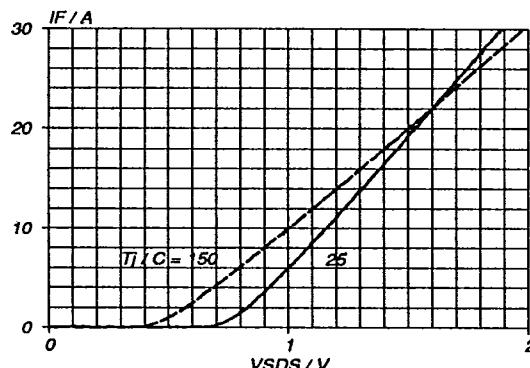


Fig. 15. Typical reverse diode current.
 $I_F = f(V_{DS})$; conditions: $V_{GS} = 0\text{ V}$; parameter T_J

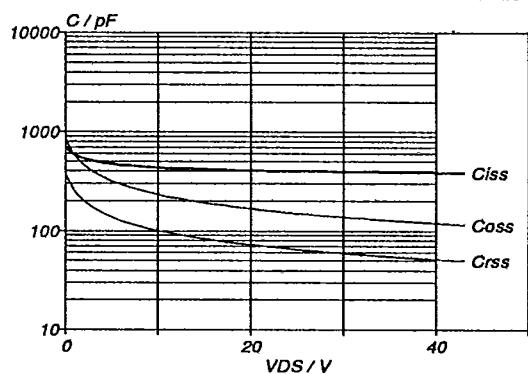


Fig. 13. Typical capacitances, C_{iss} , C_{oss} , C_{rss} .
 $C = f(V_{DS})$; conditions: $V_{GS} = 0\text{ V}$; $f = 1\text{ MHz}$

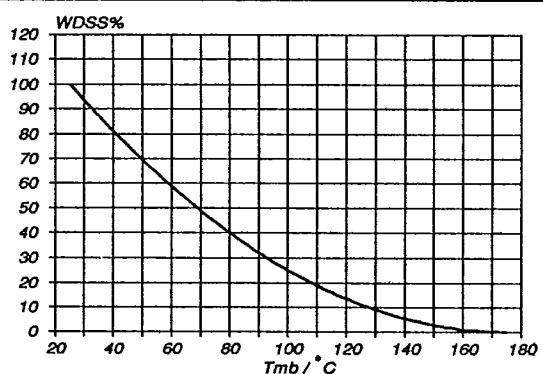


Fig. 16. Normalised avalanche energy rating.
 $W_{DSS}\% = f(T_{mb})$; conditions: $I_D = 14\text{ A}$

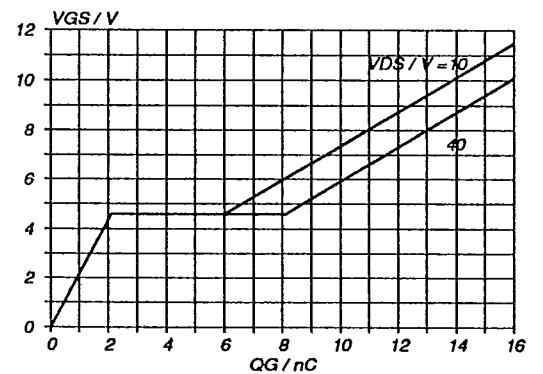


Fig. 14. Typical turn-on gate-charge characteristics.
 $V_{GS} = f(Q_G)$; conditions: $I_D = 14\text{ A}$; parameter V_{DS}

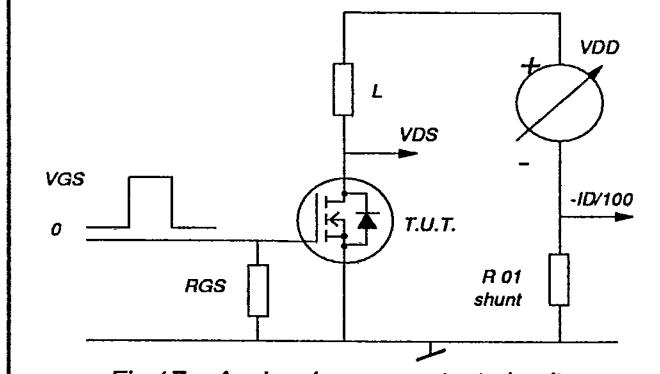


Fig. 17. Avalanche energy test circuit.
 $W_{DSS} = 0.5 \cdot L I_D^2 \cdot BV_{DSS} / (BV_{DSS} - V_{DD})$